



<p>Searched</p> 	<p>Application/Control No.</p> <p>10506560</p>	<p>Applicant(s)/Patent Under Reexamination</p> <p>PETERSEN, LEIF</p>
	<p>Examiner</p> <p>Chen, Junpeng</p>	<p>Art Unit</p> <p>2618</p>

Class	SubClass	Date	Examiner
455	127.1; 127.2	11/14/2006	J.C.
330	149; 145; 137; 129; 52; 136; 9	11/14/2006	J.C.

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Notes	Date	Examiner
EAST Image and keyword search in USPAT, US-PG Pub, DERWENT, EPO, JPO and IBM, TDB	11/14/2006	J.C.
Consulted Fayyaz Alam, Alan Wong	11/14/2006	J.C.
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